

| | | | | ATTY. DOCKET NO. 1875.2590001 | APPLICATION NO. To Be Assigned <u>10/773263</u> | | |
|--|-----|-----------------|--|---|--|-----------|-------------|
| | | | | FIRST NAMED INVENTOR Akira ITO | | | |
| | | | | FILING DATE Herewith on February 9, 2004 | ART UNIT To Be Assigned | | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB-CLASS | FILING DATE |
| <i>JMS</i> | AA1 | 5,306,656 | 04/26/1994 | Williams et al. | | | |
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| <i>JMS</i> | AD1 | 20020074616 | 06/20/2002 | Chen et al. | | | |
| <i>JMS</i> | AE1 | 20030123314 | 07/03/2003 | Buer et al. | | | |
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| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUB-CLASS | TRANSLATION |
| <i>JMS</i> | AL1 | 0 495 317 A1 | 07/1992 | EP | | | Yes |
| | AM1 | | | | | | No |
| | AN1 | | | | | | Yes |
| | AO1 | | | | | | No |
| | AP1 | | | | | | Yes |
| | | | | | | | No |
| OTHER (Including Author, Title, Date, Pertinent Pages, etc.) | | | | | | | |
| <i>JMS</i> | AR | 1 | Copy of European Search Report from EP Appl. No. 03016223.4, 4 pages (dated November 20, 2003). | | | | |
| <i>JMS</i> | AS | 1 | B. Kaczer et al., "Consistent Model for Short-Channel nMOSFET Post-Hard-Breakdown Characteristics," 2001 Symposium on VLSI Technology Digest of Technical Papers, pp. 121-122, 2001. | | | | |
| <i>JMS</i> | AT | 1 | R. Degraeve et al., "Relation Between Breakdown Mode and Location in Short-Channel nMOSFETs and its impact on Reliability Specifications," IEEE, 7 pages 2001. | | | | |
| EXAMINER <i>Jennifer M. D.</i> | | | | DATE CONSIDERED <u>6/24/04</u> | | | |
| EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant. | | | | | | | |

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| FORM PTO-1449 <u>INFORMATION DISCLOSURE STATEMENT</u> | | ATTY. DOCKET NO. 1875.2590001 | APPLICATION NO. To Be Assigned <i>10/773263</i> |
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| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB-CLASS | FILING DATE |
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| | AE2 | | | | | | |
| | AF2 | | | | | | |
| | AG2 | | | | | | |
| | AH2 | | | | | | |
| | AI2 | | | | | | |
| | AJ2 | | | | | | |
| | AK2 | | | | | | |

FOREIGN PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUB-CLASS | TRANSLATION |
|------------------|-----|-----------------|------|---------|-------|-----------|-------------|
| | AL2 | | | | | | Yes No |
| | AM2 | | | | | | Yes No |
| | AN2 | | | | | | Yes N |
| | AO2 | | | | | | Y s No |
| | AP2 | | | | | | Yes N |

OTHER (Including Author, Title, Date, Pertinent Pages, etc.)

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| | AR | <u>2</u> | |
| | AS | <u>2</u> | |
| | AT | <u>2</u> | |

EXAMINER

Chamblee JM DCL *(6/24/04)*

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